

# MOS FIELD EFFECT TRANSISTOR $\mu$ PA1913

## P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

### **DESCRIPTION**

The  $\mu$ PA1913 is a switching device which can be driven directly by a 2.5-V power source.

The  $\mu$ PA1913 features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

### **FEATURES**

- Can be driven by a 2.5-V power source
- · Low on-state resistance

RDS(on)1 = 55 m $\Omega$  MAX. (VGS = -4.5 V, ID = -2.5 A)

 $R_{DS(on)2} = 58 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = -4.0 \text{ V, ID} = -2.5 \text{ A)}$ 

 $R_{DS(on)3} = 82 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = -2.7 \text{ V, ID} = -2.5 \text{A)}$ 

 $R_{DS(on)4} = 90 \text{ m}\Omega \text{ MAX.} (V_{GS} = -2.5 \text{ V}, I_{D} = -2.5 \text{A})$ 

### ORDERING INFORMATION

PART NUMBER	PACKAGE
μPA1913TE	SC-95 (Mini Mold Thin Type)

### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25$ °C)

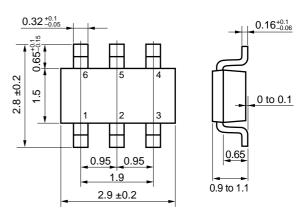
Drain to Source Voltage	VDSS	-20	V
Gate to Source Voltage	Vgss	±12	V
Drain Current (DC)	ID(DC)	±4.5	Α
Drain Current (pulse) Note1	ID(pulse)	±18	Α
Total Power Dissipation	P <sub>T1</sub>	0.2	W
Total Power Dissipation Note2	P <sub>T2</sub>	2	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

### **Notes 1.** PW $\leq$ 10 $\mu$ s, Duty Cycle $\leq$ 1 % **2.** Mounted on FR4 board, $t \le 5$ sec.

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

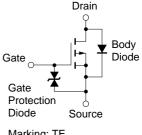
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>
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### PACKAGE DRAWING (Unit: mm)



1, 2, 5, 6 : Drain 3 : Gate : Source

### **EQUIVALENT CIRCUIT**



Marking: TE

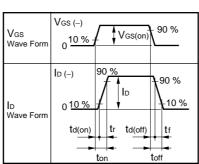


### ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C)

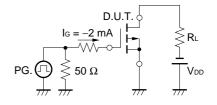
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Ipss	Vps = -20 V, Vgs = 0 V			-10	μΑ
Gate Leakage Current	lgss	Vgs = ±12 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V <sub>GS(off)</sub>	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$	-0.5	-1.1	-1.5	V
Forward Transfer Admittance	yfs	$V_{DS} = -10 \text{ V}, I_{D} = -2.5 \text{ A}$	3	8.8		S
Drain to Source On-state Resistance	RDS(on)1	Vgs = -4.5 V, ID = -2.5 A		44	55	mΩ
	RDS(on)2	Vgs = -4.0 V, ID = -2.5 A		46	58	mΩ
	RDS(on)3	Vgs = -2.7 V, ID = -2.5 A		60	82	mΩ
	RDS(on)4	Vgs = -2.5 V, ID = -2.5 A		66	90	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = -10 V		700		pF
Output Capacitance	Coss	Vgs = 0 V		208		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		100		pF
Turn-on Delay Time	td(on)	V <sub>DD</sub> = -10 V		300		ns
Rise Time	tr	I <sub>D</sub> = -2.5 A		528		ns
Turn-off Delay Time	t <sub>d(off)</sub>	$V_{GS(on)} = -4.0 \text{ V}$		242		ns
Fall Time	t <sub>f</sub>	$R_G = 10 \Omega$		698		ns
Total Gate Charge	Q <sub>G</sub>	V <sub>DD</sub> = -16 V		6.0		nC
Gate to Source Charge	Qgs	I <sub>D</sub> = -4.5 A		2.1		nC
Gate to Drain Charge	Q <sub>GD</sub>	V <sub>GS</sub> = -4.0 V		2.8		nC
Diode Forward Voltage	V <sub>F</sub> (S-D)	IF = 4.5 A, VGS = 0 V		0.86		V
Reverse Recovery Time	trr	IF = 4.5 A, VGS = 0 V		32		ns
Reverse Recovery Charge	Qrr	di/dt = 10 A / μs		2.2		nC

### **TEST CIRCUIT 1 SWITCHING TIME**

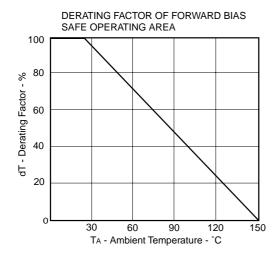
# D.U.T. RLPG. RG $V_{DD}$ $T = 1 \mu s$ Duty Cycle $\leq 1 \%$

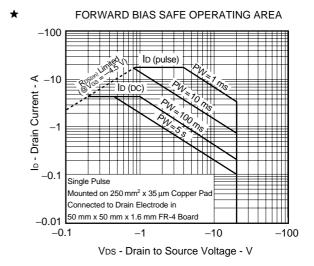


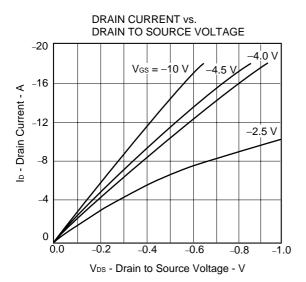
### **TEST CIRCUIT 2 GATE CHARGE**

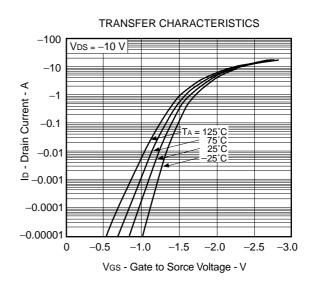


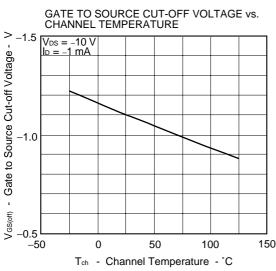
### TYPICAL CHARACTERISTICS (TA = 25°C)

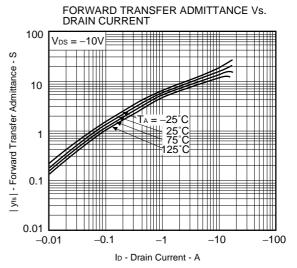




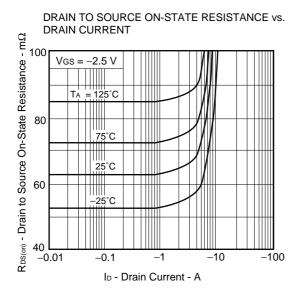


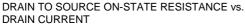


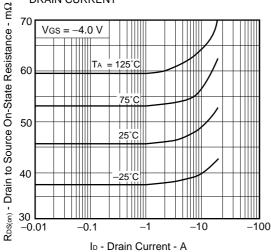




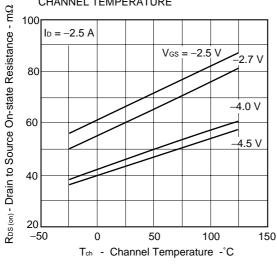
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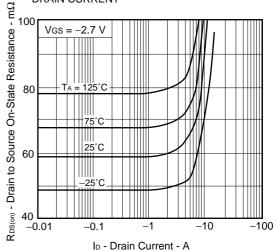




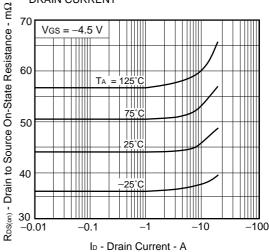
DRAIN TO SOURCE ON STATE RESISTANCE vs. CHANNEL TEMPERATURE



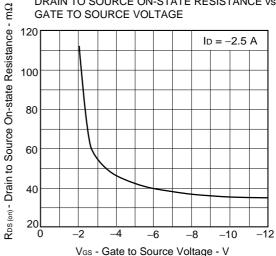
DRAIN TO SOURCE ON-STATE RESISTANCE vs. **DRAIN CURRENT** 

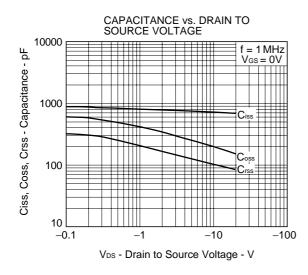


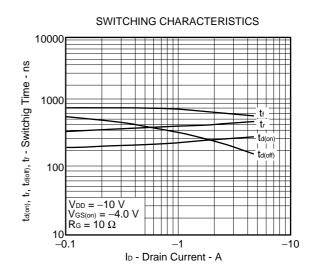
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



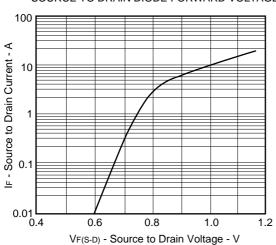
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

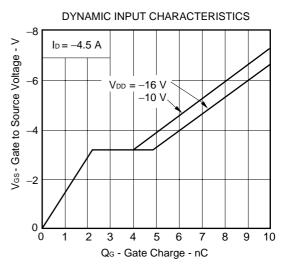




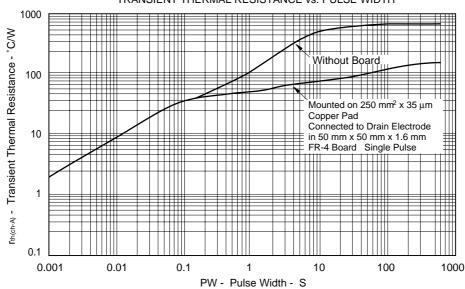


# SOURCE TO DRAIN DIODE FORWARD VOLTAGE





### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



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**μPA1913** 

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